

Hercules PLL Advisory SSWF021#45 Workaround

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ABSTRACT

This application report provides software source code and additional information on how to implement a workaround that helps to minimize the impact of Hercules Phase Locked Loop (PLL) Advisory SSWF021#45.

Project collateral and source code mentioned in this document can be downloaded from the following URL: <http://www.ti.com/lit/zip/spna233>.

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1 Background

Texas Instruments has found that on rare occasions some Hercules Safety Microcontrollers have an issue with PLL startup. While Texas Instruments does test for and screen these devices, at the time of publication of this report, our screens are not 100% effective. Parts that are affected have advisory SSWF021#45 listed in the errata document for that device, if the errata document was published in May of 2016 or later. The software workaround described in this report, while not 100% effective, significantly helps to reduce the occurrence of failures.

2 Implementation

The header file “errata_SSWF021_45.h” contains the function prototypes and should be included in the user’s source file that calls the workaround function. The header file “errata_SSWF021_45_defs.h” defines values used in the “errata_SSWF021.c” file. It makes the source file independent of HALCoGen.

NOTE: The workaround functions do not set the PLL to the customer's desired frequency, nor do they leave the PLL enabled. These steps should be performed after successful completion of the workaround routine. The PLL settings in the workaround routine were chosen to minimize the lock time and to be valid over the range of 5 MHz to 20 MHz crystal frequency. Changing these settings may affect the proper execution of the workaround routine.

2.1 Which Function to Use

There are three functions provided in the source code: one for PLL1, a second for PLL2, and the third for locking PLL1 and PLL2 at the same time

2.1.1 _errata_SSWF021_45_pll1()

This function only attempts to lock PLL1. This function is to be used on devices that have only one PLL, or in applications that do not use PLL2.

2.1.2 _errata_SSWF021_45_pll2()

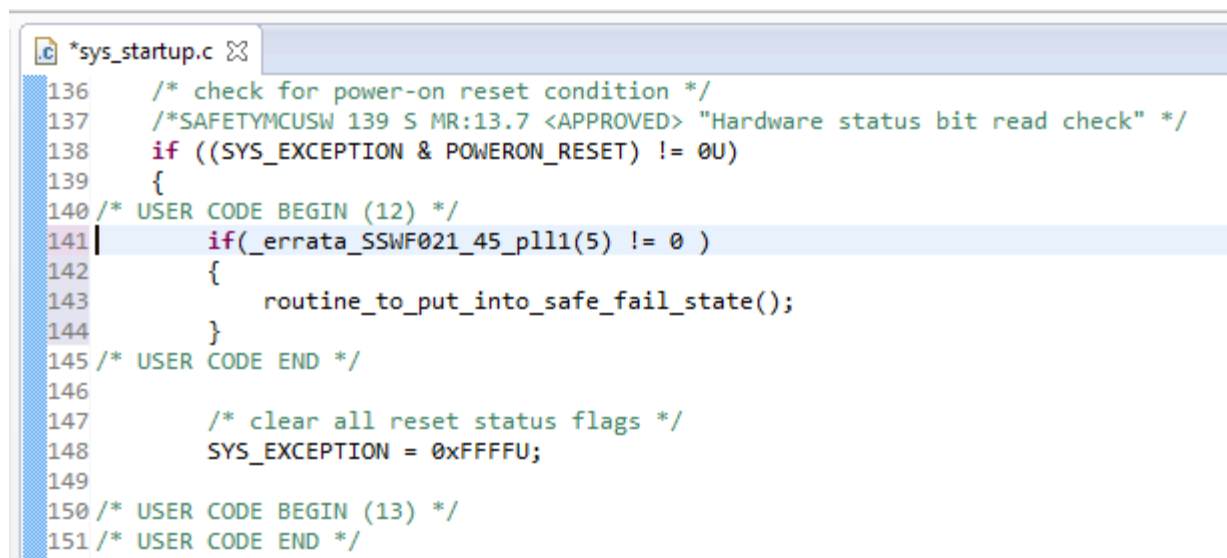
This function only attempts to lock PLL2, and is provided for completeness. Usually if PLL2 is used, both PLLs are used and the workaround function that locks both PLLs simultaneously is preferred because it reduces the overall execution time.

2.1.3 _errata_SSWF021_45_both_plls()

This function attempts to lock both PLLs simultaneously. This is the most efficient routine to use if both PLLs will be used in the application.

2.2 Where to Place the Function Call

The workaround function should be called only after a power-on reset, as it only needs to be called once per power-up. For example, in HALCoGen, the call to the workaround routine should be placed in the USER CODE section inside the check for the POWERON_RESET as shown in the example of Figure 1. HALCoGen version 4.07.01 generates start-up code that calls the PLL work-around function, so additional function calls are necessary for implementing this workaround.



```

136  /* check for power-on reset condition */
137  /*SAFETYMCUSW 139 S MR:13.7 <APPROVED> "Hardware status bit read check" */
138  if ((SYS_EXCEPTION & POWERON_RESET) != 0U)
139  {
140 /* USER CODE BEGIN (12) */
141 |   if(_errata_SSWF021_45_pll1(5) != 0 )
142     {
143         routine_to_put_into_safe_fail_state();
144     }
145 /* USER CODE END */
146
147     /* clear all reset status flags */
148     SYS_EXCEPTION = 0xFFFFU;
149
150 /* USER CODE BEGIN (13) */
151 /* USER CODE END */

```

Figure 1. Example Call to Workaround Routine

2.3 Parameters and Return Value

2.3.1 Input Parameter

There is only one input parameter, an unsigned integer "count". This parameter determines the maximum number of PLL lock attempts to try before exiting with an error. If a count of zero is given, the routine continues to attempt a proper PLL lock until successful. The value chosen for count determines the maximum execution time of the workaround function.

2.3.2 Return Value

The workaround functions return an unsigned integer that indicates the pass or fail status of the function. The possible return values are:

- 0 = Success (the PLL or both PLLs have successfully locked and then been disabled)
- 1 = PLL1 failed to successfully lock in "count" tries
- 2 = PLL2 failed to successfully lock in "count" tries
- 3 = Neither PLL1 nor PLL2 successfully locked in "count" tries
- 4 = The workaround function was not able to disable at least one of the PLLs. The most likely reason is that a PLL is already being used as a clock source. This can be caused by the workaround function being called from the wrong place in the code.

2.4 Execution Time

The execution time is a function of the crystal frequency and the number of iterations required for the PLL to lock. The maximum execution time is then a function of the maximum iterations allowed, which is the only parameter passed to the function. The `_errata_SSWF021_45_both_plls()` function minimizes execution time by locking both PLLs simultaneously. Example execution times for the single PLL `_errata_SSWF021_45_pll1()` and `_errata_SSWF021_45_pll2()` functions are shown in [Table 1](#). Example execution times for the dual PLL `_errata_SSWF021_45_both_plls()` function is shown in [Table 2](#).

Table 1. Single PLL Maximum Execution Time

Maximum Tries	5 MHz Crystal	8 MHz Crystal	16 MHz Crystal	20 MHz Crystal
1	505 μ s	316 μ s	158 μ s	126 μ s
2	1010 μ s	632 μ s	316 μ s	253 μ s
3	1515 μ s	948 μ s	474 μ s	379 μ s
4	2020 μ s	1264 μ s	632 μ s	505 μ s
5	2525 μ s	1580 μ s	790 μ s	632 μ s

Table 2. Dual PLL Maximum Execution Time

Maximum Tries	5 MHz Crystal	8 MHz Crystal	16 MHz Crystal	20 MHz Crystal
1	596 μ s	372 μ s	186 μ s	149 μ s
2	1191 μ s	744 μ s	372 μ s	298 μ s
3	1786 μ s	1116 μ s	558 μ s	447 μ s
4	2381 μ s	1488 μ s	744 μ s	596 μ s
5	2976 μ s	1860 μ s	930 μ s	744 μ s

3 Detailed Description

The purpose of the workaround routines is to get the PLL to successfully lock one time after power-on reset. The workaround routine does not initialize the PLL to the desired frequency nor does it leave the PLL enabled. After the PLL has locked once, it successfully locks each time using the desired settings until the next loss of power.

The workaround routine polls for either the clock source to be valid (PLL lock) or for a PLL slip, as indicated in the ESM register. In the case of the function that locks both PLLs simultaneously, it checks for a lock or slip in each PLL. Then, if the PLL indicates that it has locked, the frequency of the PLL is checked using the Dual Clock Compare (DCC) module. Since the DCC measures the ratio of the PLL frequency to the oscillator frequency, the routine can be used with any valid oscillator frequency without modification.

The following function is the workaround for both PLLs.

```

uint32 _errata_SSWF021_45_both_plls(uint32 count)
{
    uint32 failCode, retries, clkCntlSav;

    /* save CLKCNTL, */
    clkCntlSav = systemREG1->CLKCNTL;
    /* First set VCLK2 = HCLK */
    systemREG1->CLKCNTL = clkCntlSav & 0x000F0100U;
    /* Now set VCLK = HCLK and enable peripherals */
    systemREG1->CLKCNTL = SYS_CLKCNTL_PENA;
    failCode = 0U;
    for(retries = 0U; (retries < count); retries++)
    {
        failCode = 0U;
        /* Disable PLL1 and PLL2 */
        failCode = disable_plls(SYS_CLKSRC_PLL1 | SYS_CLKSRC_PLL2);
        if(failCode != 0U)
        {
            break;
        }

        /* Clear Global Status Register */
        systemREG1->GBLSTAT = 0x00000301U;
        /* Clear the ESM PLL slip flags */
        esmREG->SR1[0U] = ESM_SR1_PLL1SLIP;
        esmREG->SR4[0U] = ESM_SR4_PLL2SLIP;
        /* set both PLLs to OSCIN/1*27/(2*4) */
        systemREG1->PLLCTL1 = 0x23001A00U;
        systemREG1->PLLCTL2 = 0x3FC0723DU;
        systemREG2->PLLCTL3 = 0x23001A00U;
        systemREG1->CSDISCLR = SYS_CLKSRC_PLL1 | SYS_CLKSRC_PLL2;
        /* Check for (PLL1 valid or PLL1 slip) and (PLL2 valid or PLL2 slip) */
        while (((systemREG1->CSVSTAT & SYS_CLKSRC_PLL1) == 0U) && ((esmREG->SR1[0U] & ESM_SR1_PLL1SLIP) == 0U)) ||
            (((systemREG1->CSVSTAT & SYS_CLKSRC_PLL2) == 0U) && ((esmREG->SR4[0U] & ESM_SR4_PLL2SLIP) == 0U)))
        {
            /* Wait */
        }
        /* If PLL1 valid, check the frequency */
        if(((esmREG->SR1[0U] & ESM_SR1_PLL1SLIP) != 0U) || ((systemREG1->GBLSTAT & 0x00000300U) != 0U))
        {
            failCode |= 1U;
        }
        else
        {
            failCode |= check_frequency(dcc1CNT1_CLKSRC_PLL1);
        }
        /* If PLL2 valid, check the frequency */
        if(((esmREG->SR4[0U] & ESM_SR4_PLL2SLIP) != 0U) || ((systemREG1->GBLSTAT & 0x00000300U) != 0U))
        {
            failCode |= 2U;
        }
        else
        {
            failCode |= (check_frequency(dcc1CNT1_CLKSRC_PLL2) << 1U);
        }
        if (failCode == 0U)
    }
}

```

```

        {
            break;
        }
    }

    /* To avoid MISRA violation 382S
    (void)missing for discarded return value */
    failCode = disable_plls(SYS_CLKSRC_PLL1 | SYS_CLKSRC_PLL2);
    /* restore CLKCNTL, VCLKR and PENA first */
    systemREG1->CLKCNTL = (clkCntlSav & 0x000F0100U);
    /* restore CLKCNTL, VCLK2R */
    systemREG1->CLKCNTL = clkCntlSav;
    return failCode;
}

```

The *check_frequency* function is used to measure the PLL frequency using an on-chip Dual-Clock-Comparator before the PLL is used as a clock source.

```

static uint32 check_frequency(uint32 cnt1_clksrc)
{
    /* Setup DCC1 */
    /* DCC1 Global Control register configuration */
    dccREG1->GCTRL = (uint32)0x5U | /* Disable DCC1 */
                    (uint32)((uint32)0x5U << 4U) | /* No Error Interrupt */
                    (uint32)((uint32)0xAU << 8U) | /* Single Shot mode */
                    (uint32)((uint32)0x5U << 12U); /* No Done Interrupt */

    /* Clear ERR and DONE bits */
    dccREG1->STAT = 3U;
    /** DCC1 Clock0 Counter Seed value configuration */
    dccREG1->CNT0SEED = 138U;
    /** DCC1 Clock0 Valid Counter Seed value configuration */
    dccREG1->VALID0SEED = 10U;
    /** DCC1 Clock1 Counter Seed value configuration */
    dccREG1->CNT1SEED = 489U;
    /** DCC1 Clock1 Source 1 Select */
    dccREG1->CNT1CLKSRC = (uint32)((uint32)10U << 12U) | /* DCC Enable/Disable Key */
                        (uint32) cnt1_clksrc; /* DCC1 Clock Source 1 */

    dccREG1->CNT0CLKSRC = (uint32)DCC1_CNT0_OSCIN; /* DCC1 Clock Source 0 */

    /** DCC1 Global Control register configuration */
    dccREG1->GCTRL = (uint32)0xAU | /* Enable DCC1 */
                    (uint32)((uint32)0x5U << 4U) | /* No Error Interrupt */
                    (uint32)((uint32)0xAU << 8U) | /* Single Shot mode */
                    (uint32)((uint32)0x5U << 12U); /* No Done Interrupt */
    while(dccREG1->STAT == 0U)
    {
        /* Wait */
    }
    return (dccREG1->STAT & 0x01U);
}

```

Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from A Revision (June 2016) to B Revision	Page
• Updated PLL control register configurations applied for the workaround shown in Section 3	4
• Updated DCC configuration for measuring PLL output frequency in Section 3	4

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